TOTSU ET AL. 10/520,154 Art Unit Examiner 2834 Tran N. Nguyen **SEARCH NOTES SEARCHED** (INCLUDING SEARCH STRATEGY) DATE **EXMR** Subclass Examiner Class Date 310 310 INTERFERENCE SEARCHED Class Date Examiner 310

Application/Control No.

Search Notes

Applicant(s)/Patent under Reexamination